N THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re application of: Rajski et al.

Application No. 09/620,021

Filed: July 20, 2000

Confirmation No. 3823

CONTINUOUS APPLICATION AND

DECOMPRESSION OF TEST PATTERNS

TO A CIRCUIT-UNDER-TEST

Examiner: Phung M. Chung

Art Unit: 2133

Attorney Reference No. 1011-54375-01

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First Named Inventor	Rajski
Art Unit	2133
Examiner Name	Phung M. Chung

U.S. PATENT DOCUMENTS

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